Unit: mm

TOSHIBA Diode Silicon Epitaxial Planar Type

# **1SS308**

### **Ultra High Speed Switching Applications**

• Small package : SC-74A

## **Maximum Ratings (Ta = 25°C)**

Characteristic	Symbol	Rating	Unit
Maximum (peak) reverse voltage	$V_{RM}$	85	V
Reverse voltage	V <sub>R</sub>	80	V
Maximum (peak) forward current	I <sub>FM</sub>	300 (*)	mA
Average forward current	I <sub>O</sub>	100 (*)	mA
Surge current (10ms)	I <sub>FSM</sub>	2 (*)	Α
Power dissipation	Р	200	mW
Junction temperature	Tj	125	°C
Storage temperature	T <sub>stg</sub>	-55~125	°C

<sup>(\*)</sup> Unit rating. Total rating = unit rating  $\times$  1.5

### 2.9 ± 0.2 1.1 - 0.1

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SC-3H1A
1-3H1A

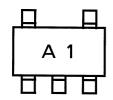
Weight: 0.014g

### **Electrical Characteristics (Ta = 25°C)**

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit	
Forward voltage	V <sub>F (1)</sub>	_	I <sub>F</sub> = 1mA	_	0.61			
	V <sub>F (2)</sub>	_	I <sub>F</sub> = 10mA	_	0.74	1	V	
	V <sub>F (3)</sub>	_	I <sub>F</sub> = 100mA	_	0.92	1.20		
Reverse current	I <sub>R (1)</sub>	_	V <sub>R</sub> = 30V	_	_	0.1	μΑ	
	I <sub>R (2)</sub>	_	V <sub>R</sub> = 80V	_	_	0.5		
Total capacitance	C <sub>T</sub>	_	V <sub>R</sub> = 0, f = 1MHz	_	2.2	4.0	pF	
Reverse recovery time	t <sub>rr</sub>	_	I <sub>F</sub> = 10mA, Fig.1	_	1.6	4.0	ns	

1

## Marking



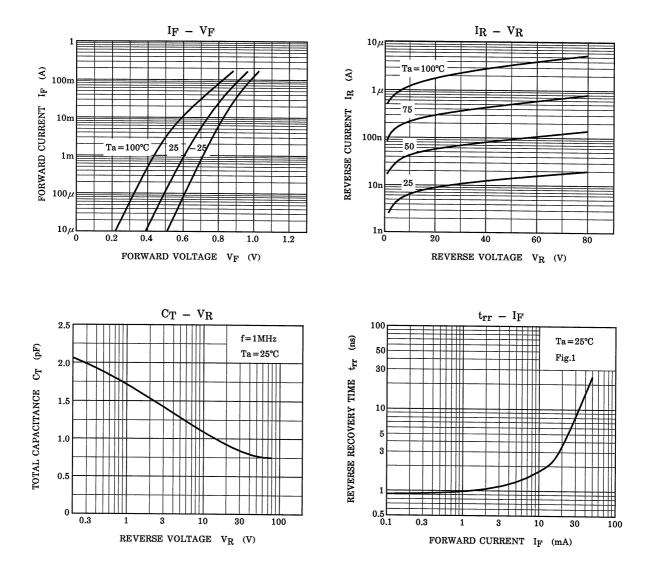
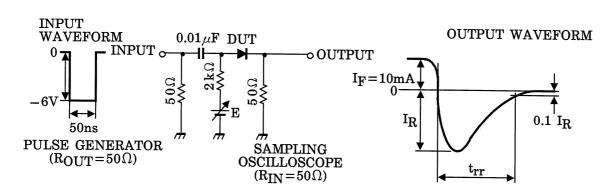


Fig.1 Reverse Recovery Time (t<sub>rr</sub>) Test Circuit



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